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FORM PTO 1449 (modified)				00862.109138.	APPLICATION NO. 10/566,170		
U. P/	S. DEPARTMENT OF	F COMMERC MARK OFFIC	E .IAN 2 2 2008	YOSHINOBU SEKIGUCHI, et al.			
LIST OF REFERENCES CITED BY APPLICATION (Use several sheets if necessary)				371(c) DATE  January 27, 2006		GROUP 2818	
	<u>- — — — — — — — — — — — — — — — — — — —</u>			U.S. PATENT DOCUMENTS		<del></del>	
*EXAMINER INITIAL	DOCU		DATE	NAME	CLASS	SUBCLASS	FILING DATE
	6,867	',110 <u> </u>	03/15/05	Yanagita, et al.	438	459	
	6,376	5,332	04/23/02	Yanagita, et al.	438	458	
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FOREIGN PATENT DOCUMENTS							
	DOCU		DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATIONYES/NO/ OR ABSTRACT
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		01	THER DOCUMENT(S	) (Including Author, Title, Date, Pertiner	nt Pages, Etc.)		

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

DATE CONSIDERED

Sheet\_1\_ of \_1\_

EXAMINER